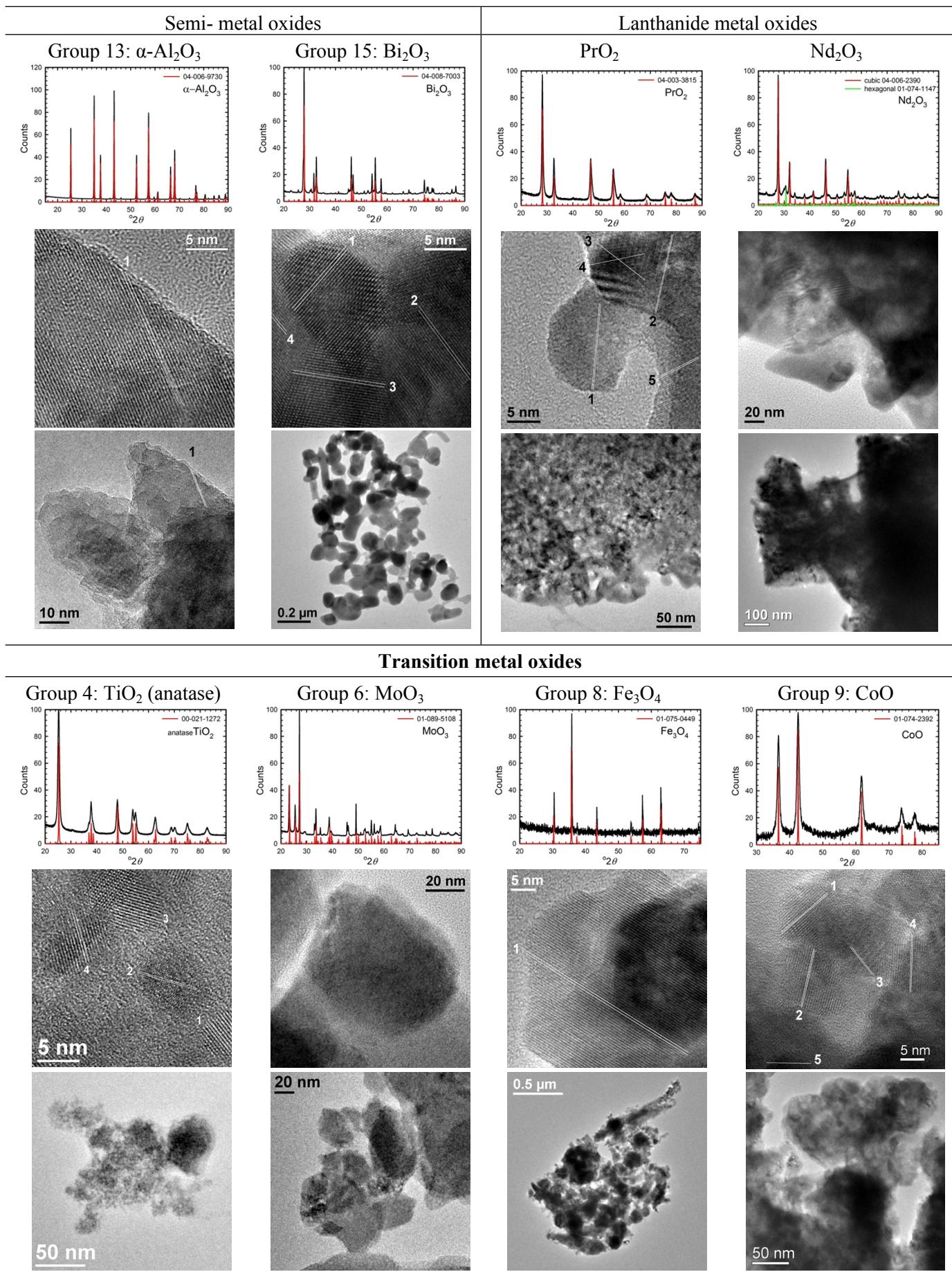


Supplemental Material

Figure S1.



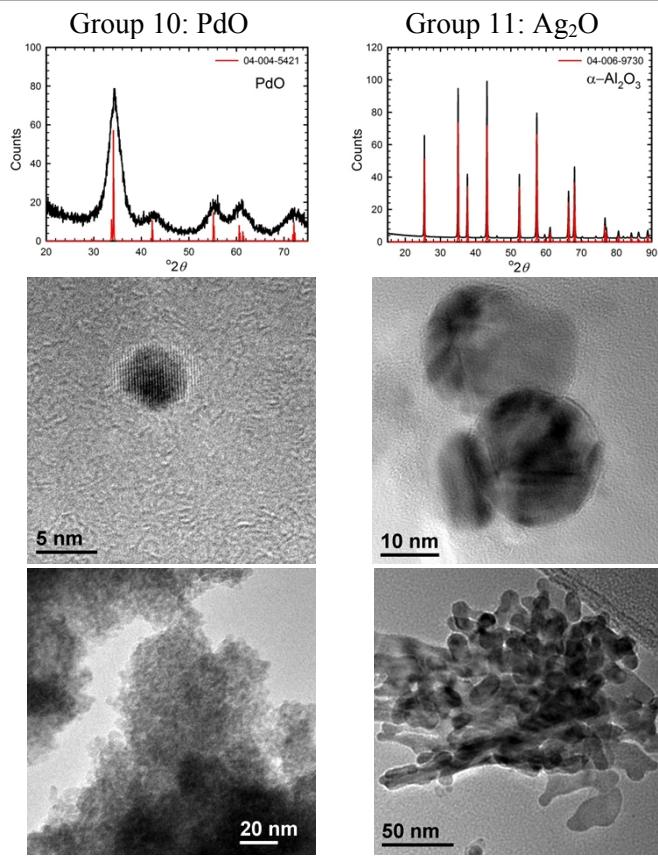


Figure S1. XRD patterns and TEM images of metal oxide nanomaterials synthesized using the solvent-deficient method. The XRD plots show the ICDD standard pattern (red line) matched to the product (black line), with the standard's PDF number given in the legend. The numbered lines in the high-resolution TEM images highlight the lattice fringes whose d-spacings and crystal plane indices are given in Table S2 in the supplemental material.

Table S1. Measured d-spacings (column A) and crystal plane indices (column C) of the highlighted/numbered lattice fringes in the high-resolution TEM images compared to the d-spacings of the standard (column B) matched to each compound in the XRD analyses.

Transition metal oxides				Semi-metal oxides						
		A	B	C		A	B	C		
Group 3	Y_2O_3	(1) 3.04	3.09	222	Group 13	$\gamma\text{-Al}_2\text{O}_3$	(1) 2.37	2.28	222	
		(2) 1.88	1.89	440			(2) 2.37	2.28	222	
Group 4	TiO_2	(1) 3.52	3.52	101	Group 13		(3) 2.05	1.98	400	
		(2) 2.38	2.38	004						
		(3) 3.52	3.52	101						
		(4) 3.51	3.52	101						
Group 4	ZrO_2	(1) 3.36	3.36	110	Group 13	In_2O_3	(1) 2.99	2.93	222	
		(2) 2.66	2.65	101			(2) 2.99	2.93	222	
		(3) 3.36	3.36	110			(3) 2.57	2.54	400	
Group 7	Mn_2O_3	(1) 4.98	4.71	200			(4) 4.21	4.14	211	
		(2) 2.77	2.72	222			(5) 4.21	4.14	211	
		(3) 4.98	4.71	200						
Group 8	Fe_2O_3	(1) 2.75	2.70	10 $\bar{1}$ 4	Group 15	Bi_2O_3	(1) 3.21	3.19	201	
		(2) 3.72	3.68	01 $\bar{1}$ 2			(2) 3.21	3.19	201	
		(3) 2.22	2.21	11 $\bar{2}$ 3			(3) 3.21	3.19	201	
Group 8	Fe_3O_4	(1) 4.84	4.82	111			(4) 2.82	2.81	002	
		(1) 2.44	2.45	111						
Group 9	CoO	(2) 2.45	2.45	111	Group 14	SnO_2	(1) 3.14	3.14	111	
		(3) 2.44	2.45	111			(2) 2.66	2.65	101	
		(4) 2.45	2.45	111			(3) 3.36	3.36	110	
		(5) 2.13	2.13	200						
Group 9	Co_3O_4	(1) 4.69	4.67	111	Group 13	CeO_2	(1) 1.97	1.93	220	
		(2) 2.91	2.86	220			(2) 1.97	1.93	220	
		(3) 2.91	2.86	220			(3) 1.69	1.65	311	
		(4) 4.69	4.67	111			(4) 1.69	1.65	311	
		(5) 4.69	4.67	111						
Group 10	NiO	(1) 2.09	2.09	200						
		(2) 2.09	2.09	200						
Group 11	CuO	(1) 2.51	2.53	1 $\bar{1}$ 1	Group 12	PrO_2	(1) 1.97	1.93	220	
		(2) 2.34	2.33	111			(2) 1.97	1.93	311	
		(3) 2.33	2.33	111			(3) 1.69	1.65	311	
Group 12	ZnO	(1) 2.53	2.48	10 $\bar{1}$ 1			(4) 1.69	1.65		

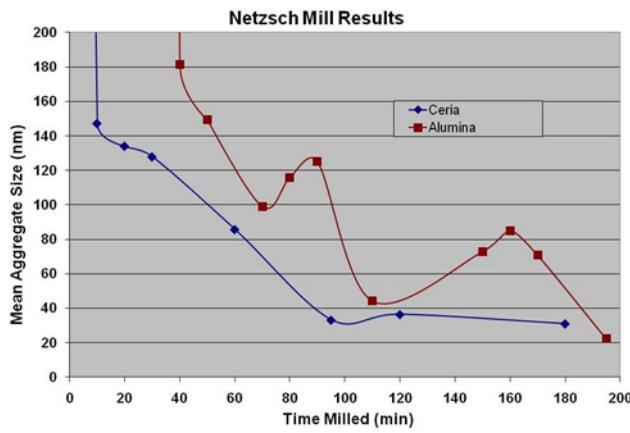
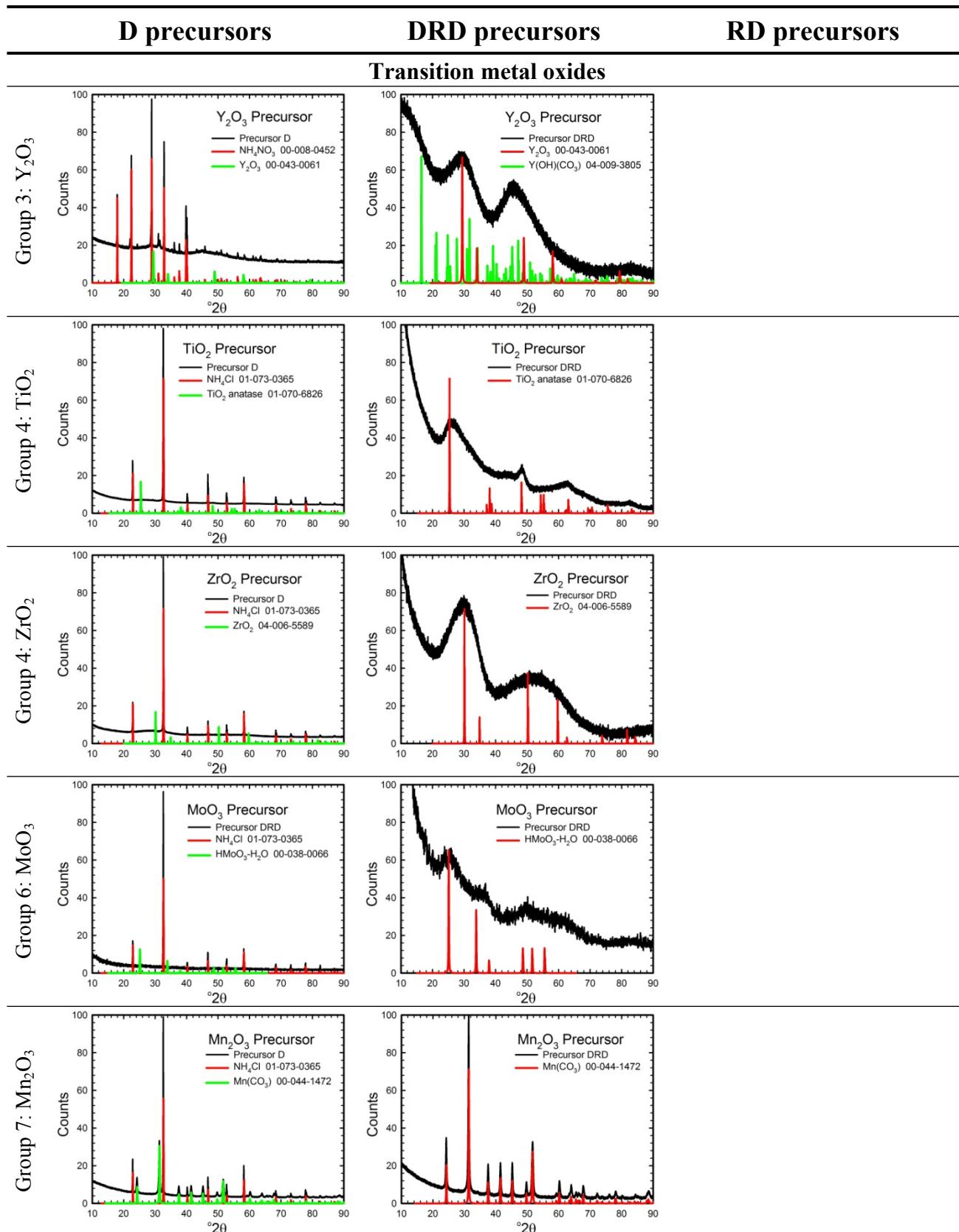
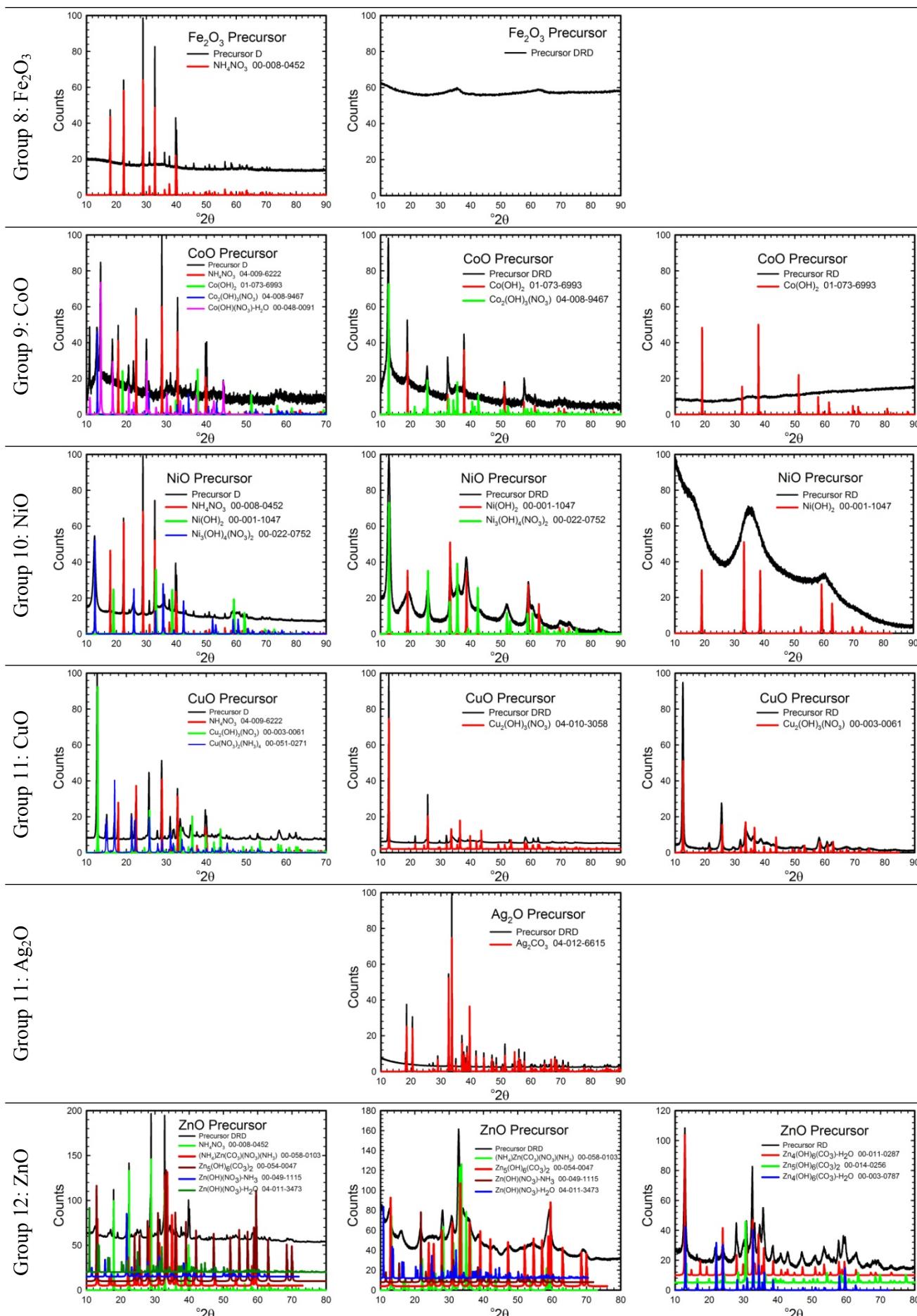


Figure S2. Preliminary Netzsch milling results for the Al_2O_3 (alumina) and CeO_2 (ceria) nanomaterials showing the average agglomerate size as a function of milling time in aqueous solution.

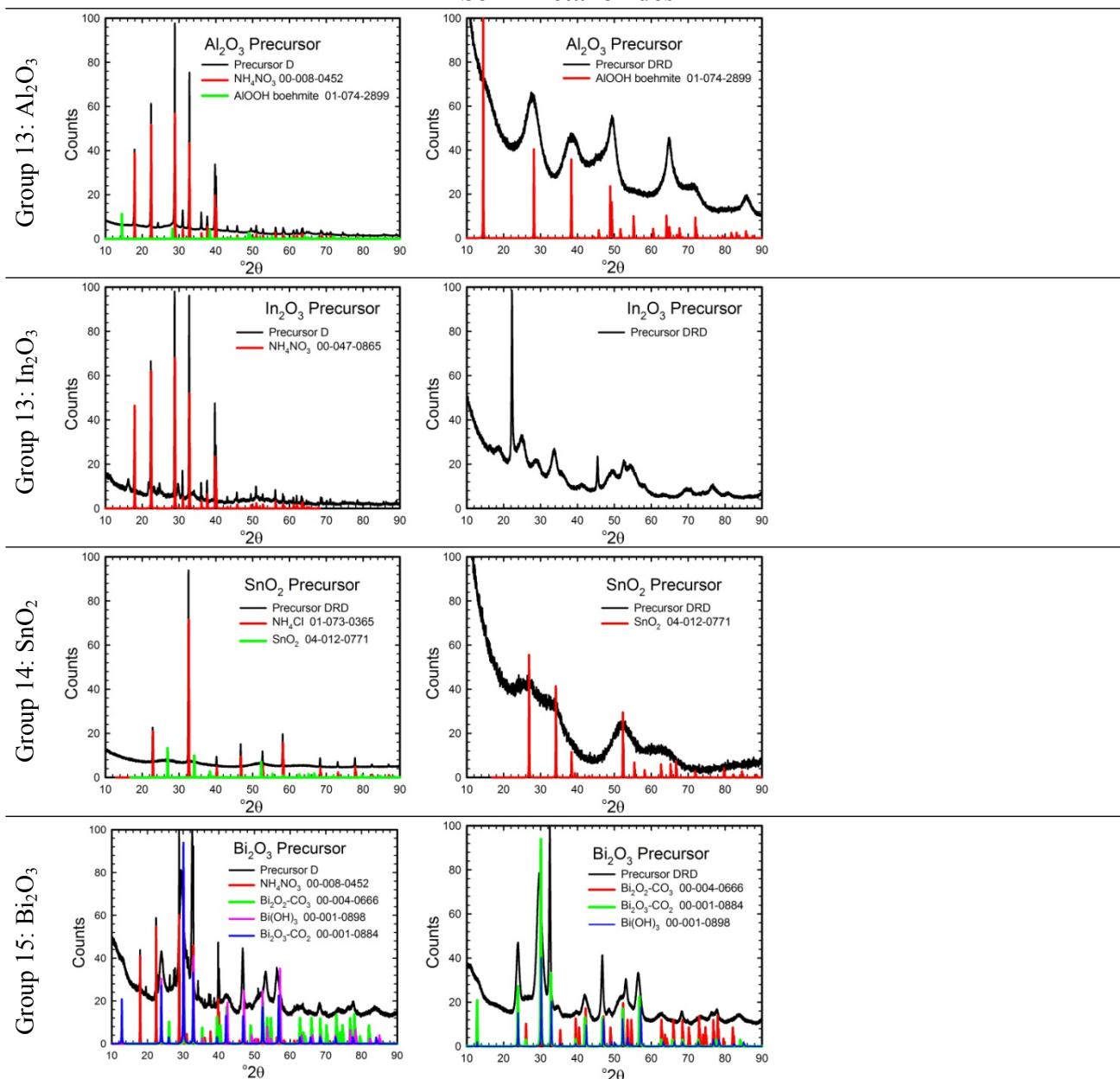
Though the initial sizes ($>200\text{nm}$) of the agglomerates were quite large, the Netzsch mill de-agglomerated both samples easily in water (with the pH controlled to be between 5-6 for the Al_2O_3), resulting in agglomerate sizes of $22 (\pm 15)$ nm and $31 (\pm 19)$ nm for the Al_2O_3 and CeO_2 samples, respectively, after only 3 and 1.5 hours of milling, respectively. These agglomerate sizes correspond roughly to five Al_2O_3 and two CeO_2 nanoparticles across, providing additional confirmation that our nanomaterials are soft agglomerates of relatively easily separated nanoparticles, not polycrystalline materials.

Figure S3. XRD patterns/analyses of the dried (D), dried-rinsed-dried (DRD), and rinsed-dried (RD) precursors (where applicable) plotted with the ICDD standard patterns of the materials they contain. The identities and PDF numbers of the standard patterns are given in the legend of each graph.

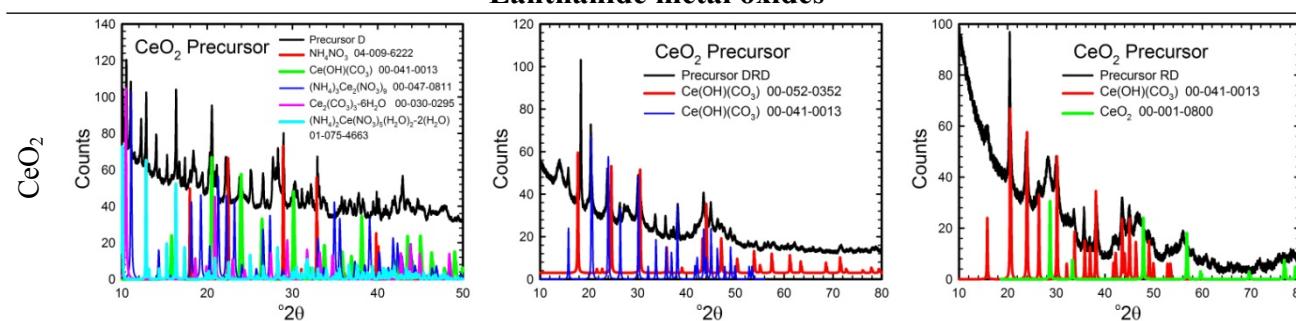




Semi-metal oxides



Lanthanide metal oxides



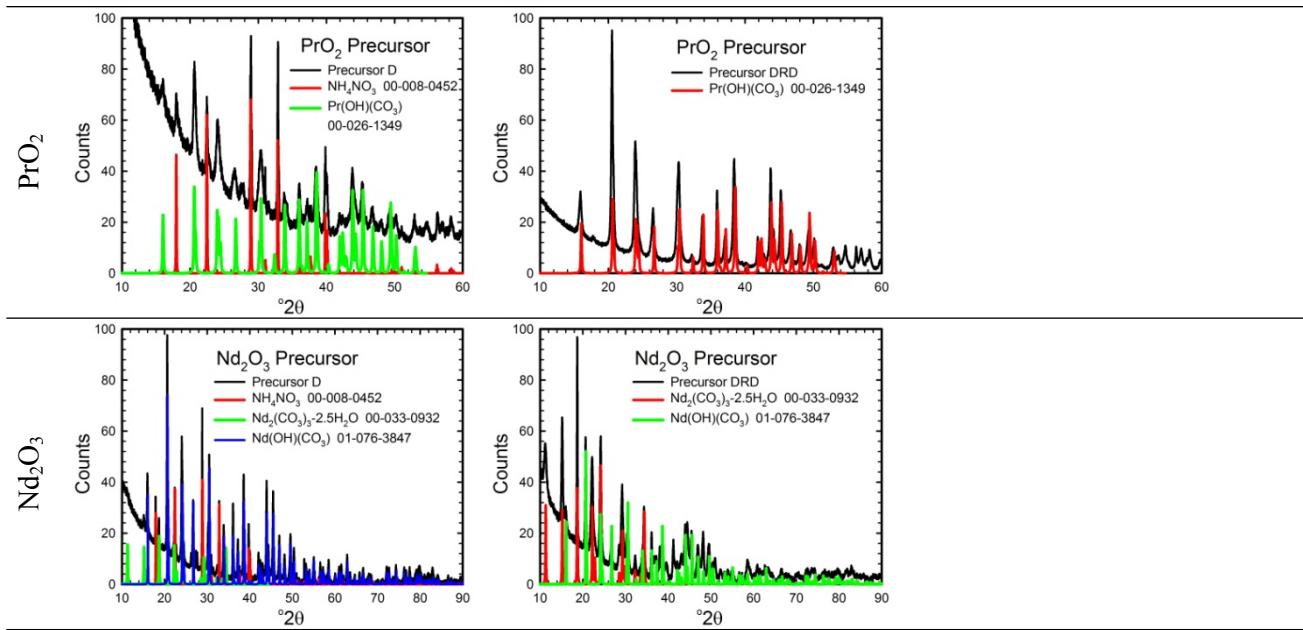
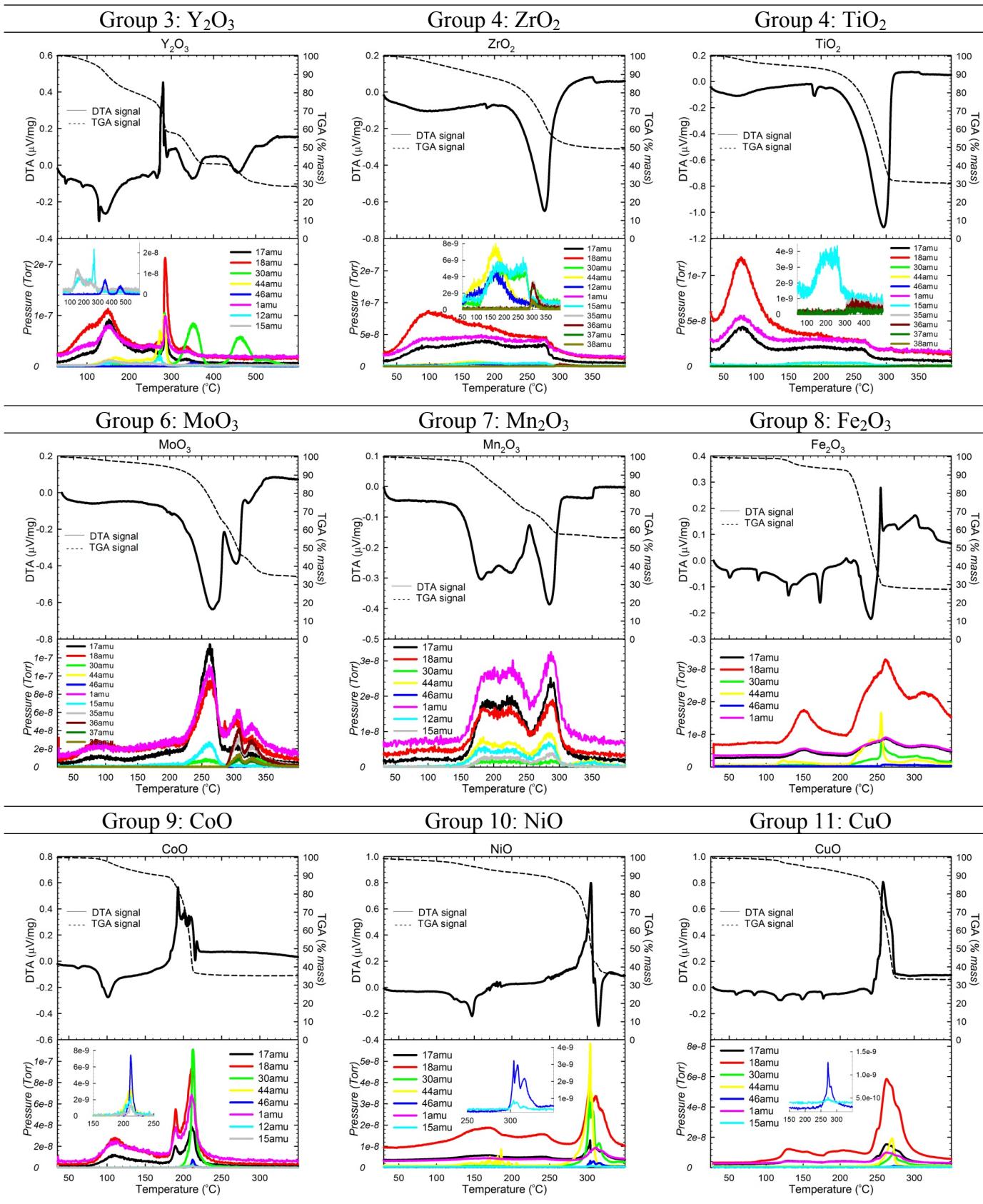


Figure S4. TG/DTA-MS data for the dried (un-rinsed) precursors. Positive and negative DTA values correspond to exothermic and endothermic events, respectively.



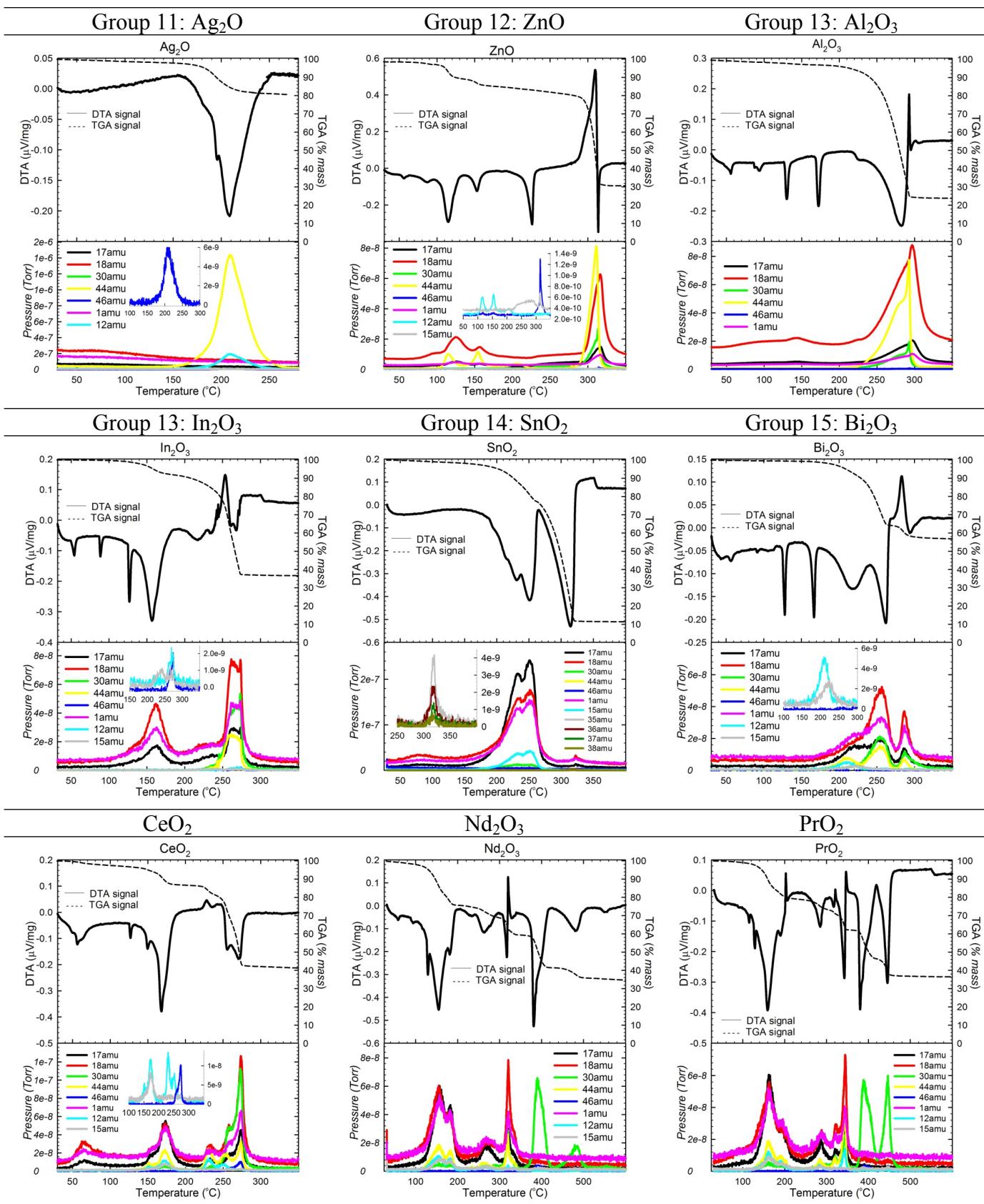
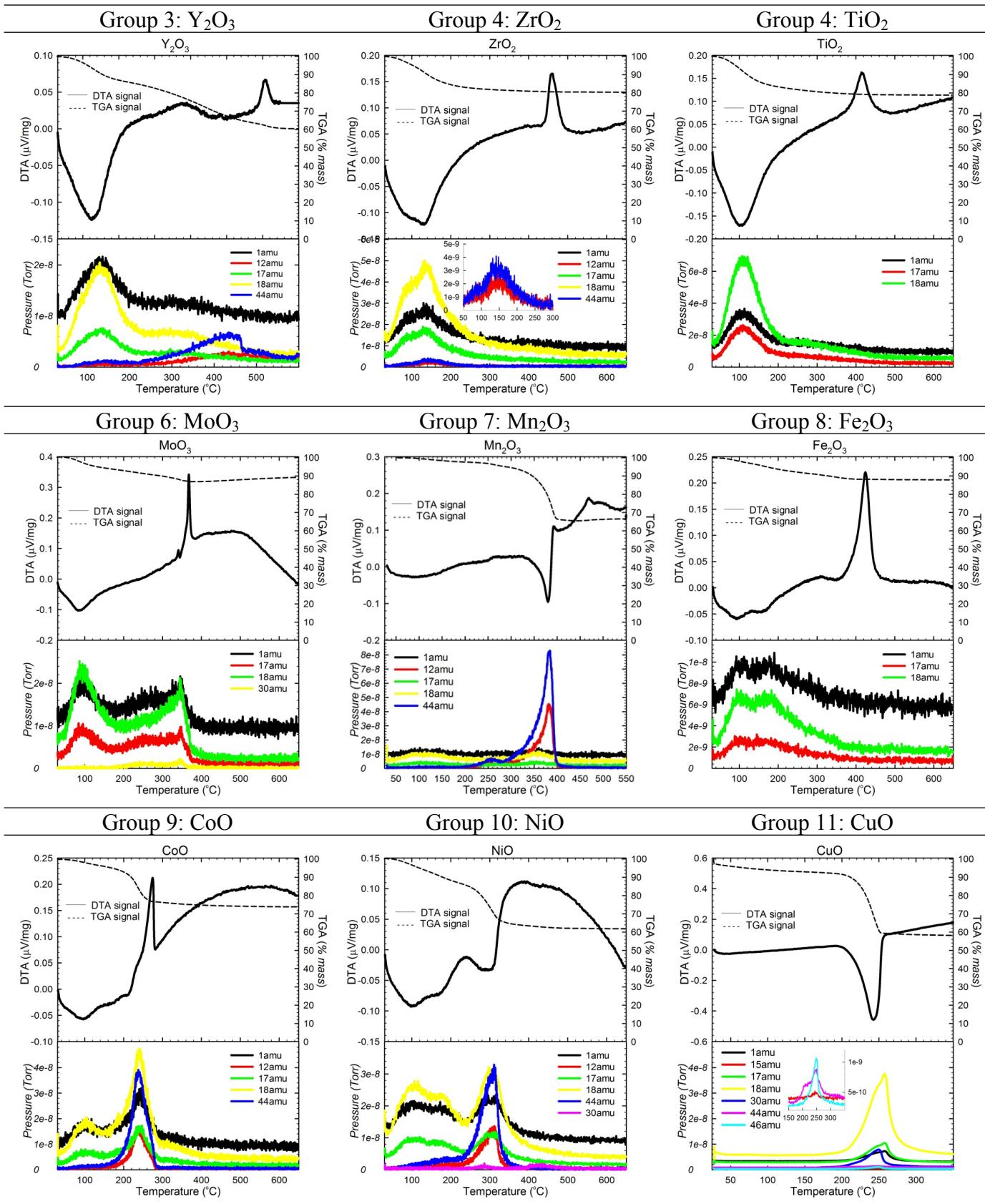
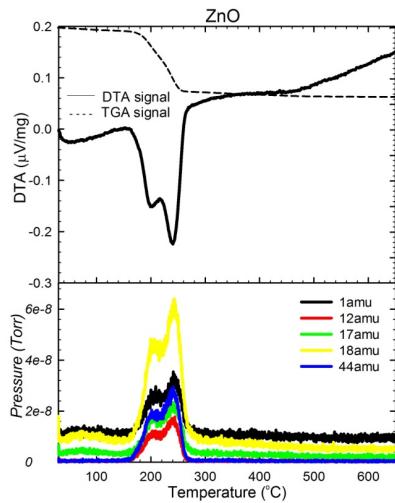
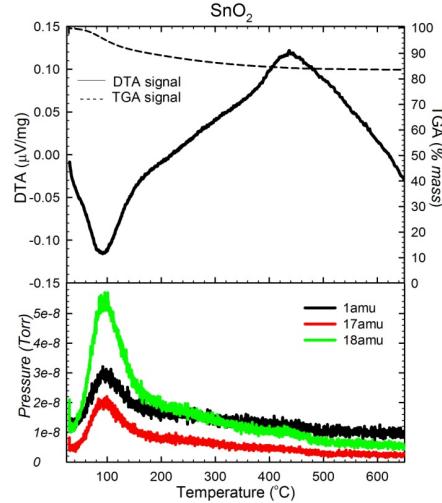


Figure S5. TG/DTA-MS data of the calcination of rinsed precursors.



Group 12: ZnO

Group 14: SnO₂Group 15: Bi₂O₃